

Application/Control	No. Applicant(s)/Pater Reexamination	Applicant(s)/Patent under Reexamination	
10/032,622	BESER, NURET	TIN BURCAK	
Examiner	Art Unit		
Hong Cho	2616		

SEARCHED				
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Class	Subclass	Date	Examiner	
370	450, 451, 458, 468, 503, 509	7/21/2006	нс	
	512, 516			
375	356			
455	450, 451	7/28/2006	нс	
	451.2,			
	509			
	512			
725	111	7/28/2006	нс	
above	UPDATED	5/16/2007	нс	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH) .
	DATE	EXMR
consulted Chau Nguyen for search help in class 370 and 375	7/20/2006	нс
consulted Doris To for search help in class 455	7/28/2006	нс
725/111 (text search - see search history printout)	7/31/2006	нс